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Sheet

~~MAR 26 2006~~

of

Attorney Docket Number 80398.P341

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FOREIGN PATENT DOCUMENTS

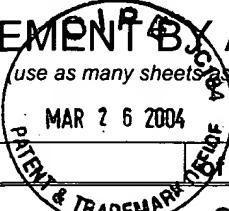
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Substitute for Form 1449A/PTO (Modified)			Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <small>(use as many sheets as necessary)</small> <small>MAR 26 2004</small>			Application Number	09/767,647
			Filing Date	1/22/01
			First Named Inventor:	Rising III.
			Group Art Unit	2621
			Examiner Name	Sherali, I.
			Attorney Docket Number	80398.P341
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Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published		T ²
15		Sahiner, et al., "Iterative Inversion of the Radon Transform: Using Image-Adaptive Wavelet Constraints to Improve Image Reconstructions", IEEE Engineering in Medicine and Biology, Sept. 1996, Vol.15, Iss 5, pp.112-117.		
15		Calzone, et al., "Video Compression by Means-Corrected Motion Compensation of Partial Quadtrees", IEEE Transactions on Circuits and Systems for Video Technology, Vol.7, No.1, Feb.1997, pp.86-96.		
15		Hsung, et al. "The Wavelet Transform of Higher Dimension and the Radon Transform", 1995 International Conference on Acoustics, Speech and Signal Processing, May 1995, Vol.2, pp.1113-1116.		
15		Warrick, et al., "A Wavelet Localized Radon Transform Based Detector for a Signal with Unknown Parameters", 1995 Conference Record of the 29 th Asilomar Conference on Signals, Systems and Computers", Oct. 1995, Vol.2, pp.860-866.		
15		Warrick, et al., "Detection of Linear Features Using a Localized Radon Transform with a Wavelet Filter", 1997 IEEE Intl. Conference of Acoustics, Speech and Signal Processing, April 1997, Vol.4, pp.2769-2772.		
15		Rashid-Farrokh, et al., "Localized Wavelet Based Computerized Tomography", Proceedings of the Intl. Conference on Image Processing, Oct.1995, Vol.2, pp.445-448.		
15		Meir, et al., "Stochastic Approximation by Neural Networks Using the Radon and Wavelet Transforms", Proceedings of the 1998 IEEE Signal Processing Society Workshop, Aug.1998, pp.224-233.		
15		Rashid-Farrokh, et al., "Wavelet-Based Multiresolution Local Tomography", IEEE Transactions on Image Processing, Vol.6, No.10, Oct.1997, pp.1412-1430.		
15		Destefano, et al., "Wavelet Localization of the Radon Transform in Even Dimensions", Proceedings of the IEEE-SP International Symposium on Time-Frequency and Time-Scale Analysis, Oct.1992, pp.137-140.		
15		Olson, et al., "Wavelet Localization of the Radon Transform", IEEE Transactions on Signal Processing, Vol.42, No.8, Aug.1994, pp.2055-2067.		
15		Sahiner, et al., "Iterative Inversion of the Radon Transform using Image-Adaptive Wavelet Constraints", Proceedings of the 1998 International Conference on Image Processing, Oct.1998, Vol.2, pp.709-713.		
15		Takizawa, et al., "Ultrasonic Tomography using Arc Focusing Beam", 1998 IEEE Ultrasonics Symposium, Oct.1998, Vol.2, pp.1659-1662.		

Examiner Signature		Date Considered	8/10/04
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Application Number	09/767,647
Filing Date	1/22/01
First Named Inventor:	Rising III.
Group Art Unit	2621
Examiner Name	Sherali, I.

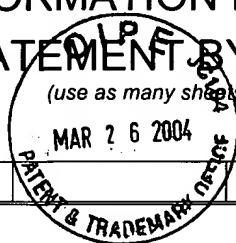
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15		Sahiner, et al., "On the Use of Wavelets in Inverting the Radon Transform", Conference Record of the 1992 IEEE Nuclear Science Symposium and Medical Imaging Conference, Oct.1992, Vol.2, pp.1129-1131.	
15		Rodenas, et al., "A New Automatic Internal Wave Detection and Characterization Method for SAR Images", OCEANS '98 Conference Proceedings, Sept.1998, Vol.2, pp.613-618.	
15		Sahiner, et al., "Iterative Inversion of the Radon Transform Using Image-Adaptive Wavelet Constraints", 18 th Annual Intl. conference of the IEEE Engineering in Medicine and Biology Society, Oct.1996, Vol.2, pp.772-723.	
15		Lu, et al., "Directional Noise Removal from Aerial Imagery using Wavelet X-Ray Transform", 1998 IEEE International Geoscience and Remote Sensing Symposium Proceedings, Vol.4, July 1998, pp.2038-2040.	
15		Magli, et al., "A Pattern Detection and Cmpression Algorithm Based on the Joint Wavelet and Radon Transform", 13 th Intl.Conference on Digital Signal Processing, July 1997, Vol.2, pp.559-562.	
15		Rising, "Inversion Processed in the Human Visual System", vol.3959 (6/2000), Sony MediaSoft Labs, US. Research Labs, San Jose, CA, pp.400-410.	
15		Albanesi, "Thresholding Wavelets for Image Compression", 1998, IEEE, University of Pavia, Dipartimento di Informatica e Sistemistica, pp.374-389.	
15		Ahmed, et al., "Application of Multi-layer Neural Networks to Image Compression", 1997 IEEE, International Symposium on Circuits and Systems, June 9-12, 1997 Hong Kong, pp.1273-1276.	
15		Carroll, et al., "Construction of Neural Nets Using the Radon Transform", Department of Electrical Engineering Princeton University, IJCNN International Joint Conference on Neural Networks, June 19-22, 1898, p.607-611.	
15		Khuwaja, et al., "Fingerprint Image Compression", Physics Department, Kuwait University, IEEE, pp.517-526	
15		Fanghanel, et al., "Optimizing Wavelet Transform Coding Using a Neural Network", 1997 IEEE, Universitat der Bundeswehr Hamburg, pp.1341-1343.	

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